
Mark K. Han

3763

SEARCHED			
Class	Subclass	Date	Examiner
604	93.01 96.01	5/25/2005	melh.
	158		
	164.01		
	164.02		
	164.07		
	167.01		
	167.02		
	167.06		
	171 256		
	261 500		
	506 507		
	508 509		
	510 513		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]

Search Notes (continued)

Application/Control No.

09/108,189

Examiner

Mark K. Han

Applicant(s)/Patent under
Reexamination

TANNER ET AL.

Art Unit

3763

SEARCHED

Class	Subclass	Date	Examiner
606	192	5/25/2005	mlh.
↓	194	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR